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EMC Test Report

Application No. : HX201002060386

Applicant: Shenzhen Meiduojiao Technology Co., Ltd.

Equipment Under Test (EUT)

EUT Name : Facial Cleansing Brush

Model No. : GT1933

Serial No. : N/A

Brand Name : N/A

Receipt Date : 2020-09-30

Test Date : 2020-09-30 to 2020-10-13

Issue Date : 2020-10-13

Standards : EN 55014-1: 2017

EN 55014-2: 2015

Conclusions : PASS

In the configuration tested, the EUT complied with the standards specified above. The EUT technically

Web: www.hx-lab.com

complies with the 2014/30/EU directive requirements.

Test/Witness Engineer

: Tim Chen

Tel: +86 755-29116082





Approved & Authorized

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.



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1. General Information

1.1. Client Information

Applicant	:	Shenzhen Meiduojiao Technology Co., Ltd.
Address	:	Room 108, Office Building 96, Yangyong Road, Tangxiayong Community, Yanluo Street, Baoan District, Shenzhen
Manufacturer	:	Shenzhen Meiduojiao Technology Co., Ltd.
Address	:	Room 108, Office Building 96, Yangyong Road, Tangxiayong Community, Yanluo Street, Baoan District, Shenzhen

1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Facial Cleansing Brush
Model No.	:	GT1933
Serial No.	:	N/A
Brand Name	:	N/A
Power Supply	:	DC 3V, 135-180mA

Remark: All above models are identical in schematic, structure and critical components except for only different appearance; therefore, EMC testing was performed with GT1933 only.

1.3. Block Diagram Showing the Configuration of System Tested

EUT

1.4. Description of Support Units

The EUT has been tested as an independent unit.



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1.5. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance of loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.6. Classification of Apparatus

Category I: Apparatus containing no electronic control circuitry.

Category II: Transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus(for example-UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

Category III: Battery powered apparatus (with built-in batteries or external batteries), which in normal use is not connected to the mains, containing an electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

This category includes apparatus provided with rechargeable batteries which can be charged by connecting the apparatus to the mains power. However, this apparatus shall also be tested as an apparatus in category III while it is connected to the mains network.

Category IV: All other apparatus covered by the scope of this standard.

1.7. Test Facility

The testing report were performed by the The testing report were performed by the Shenzhen HX Detect Certification Co., Ltd., in their facilities located at 5/F, Building B15, Zongtai Cultural and Creative Industrial Park, Yintian Creative Park, Xixiang Town, Bao 'an District, Shenzhen.





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2. Test Results Summary

EMISSION					
Description of test items	Standards	Results			
Conducted disturbance at mains terminals	EN 55014-1: 2017	N/A			
Disturbance Power	EN 55014-1: 2017	N/A			
Click measurement	EN 55014-1: 2017	N/A			
Radiated disturbance	EN 55014-1: 2017	Pass			
Harmonic current emissions	EN61000-3-2: 2019	N/A			
Voltage fluctuation and flicker	EN61000-3-3: 2013	N/A			
	IMMUNITY				
Description of test items	Basic Standards	Results			
Electrostatic Discharge (ESD)	EN61000-4-2: 2009	Pass			
Radio-frequency, Continuous Radiated Disturbance	EN61000-4-3: 2006 + A1: 2008 + A2: 2010	Pass			
EFT/B Immunity	EN61000-4-4: 2012	N/A			
Surge Immunity	EN61000-4-5: 2014	N/A			
Conducted RF Immunity	EN61000-4-6: 2014	N/A			
Voltage dips, 40% reduction					
Voltage dips, 70% reduction	EN61000-4-11: 2004	N/A			
Voltage interruptions					
Note: N/A is an abbreviation for Not App	olicable.	·			



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3. Test Equipment Used

	· ·		cted Emission		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.02, 2020	1 Year
HX-EMC002	AMN	Rohde & Schwarz	ENV216	Jan.02, 2020	1 Year
HX-EMC003	AMN	SCHWARZBECK	NNBL 8226	Jan.02, 2020	1 Year
3.2. Test Ed	juipment Used to	Measure Disturb	ance Power		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.02, 2020	1 Year
HX-EMC028	Power Clamp	Luthi	MDS-21	Jan.02, 2020	1 Year
3.3. Test Ed	uipment UseTes	t Equipment Use	d to Measure R	adiated Emiss	ion
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Jan.02, 2020	1 Year
HX-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Jan.02, 2020	1 Year
HX-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A
3.4. Test Ed	juipment Used to	Measure Harmon	nic Current/ Vol	tage Fluctuati	on and Flickei
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS-40	Jan.02, 2020	1 Year
3.5. Test Ed	uipment Used to	Measure Electro	static Discharg	e Immunity	
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC008	ESD Tester	TESEQ	NSG437	Jan.02, 2020	1 Year
3.6. Test Ed	uipment Used to	Measure Condu	cted Immunity		
HX-EMC009	RF Generator	FRANKONIA	CIT-10/75	Jan.02, 2020	1 Year
HX-EMC010	Attenuator	FRANKONIA	59-6-33	Jan.02, 2020	1 Year
HX-EMC011	M-CDN	LUTHI	M2/M3	Jan.02, 2020	1 Year
HX-EMC012	CDN	LUTHI	AF2	Jan.02, 2020	1 Year
LIV EMO040	EM Injection	LUTHI	EM101	Jan.02, 2020	1 Year
HX-EMC013	Clamp				





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3.7. Test Eq	uipment Used to	Measure Radio F	requency Ele	ctromagnetic Fi	ields Immunity
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Jan.02, 2020	1 Year
HX-EMC015	Power Meter	Rohde & Schwarz	NRVD	Jan.02, 2020	1 Year
HX-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC018	Power Amplifier	AR	150W1000	Jan.02, 2020	1 Year
HX-EMC019	Bilog Antenna	Chase	CBL6111C	Jan.02, 2020	1 Year
3.8. Test Eq	uipment Used to	Measure Electri	cal Fast Trans	ient/Burst Imm	unity
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC020	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC021	Auto-transformer	EMTEST	V4780S2	Jan.02, 2020	1 Year
3.9. Test Eq	uipment Used to	Measure Surge	lmmunity		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year
3.10. Test E	quipment Used	to Measure Volta	ge Dips and In	terruptions Imn	nunity
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year



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4. Conducted Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

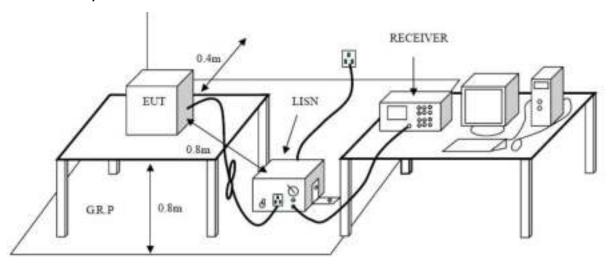
EN 55014-1: 2017.

4.1.2. Test Limit

Conducted Disturbance Test Limit

Eroguenov	Maximum RF Line Voltage (dBμV)				
Frequency	Quasi-peak Level	Average Level			
150kHz~350kHz	66 ~ 56*	56 ~ 46 *			
350kHz~5MHz	56	46			
5MHz~30MHz 60 50					

4.2. Test Setup



4.3. Test Procedure

The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/50uH of coupling impedance for the measuring instrument.

Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.

I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.



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LISN at least 80 cm from nearest part of EUT chassis.

The bandwidth of EMI test receiver is set at 9kHz, and the test frequency band is from 0.15MHz to 30MHz.

4.4. Test Condition

Temperature	:	25 ℃
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	DC 3V

4.5. Test Data

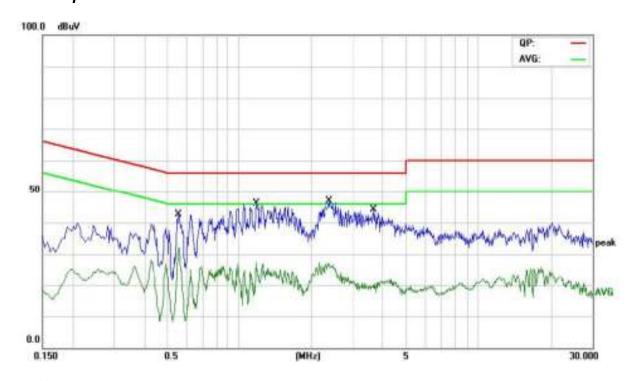
Please refer to the following pages.





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Operating Condition: Normal Test Specification: L



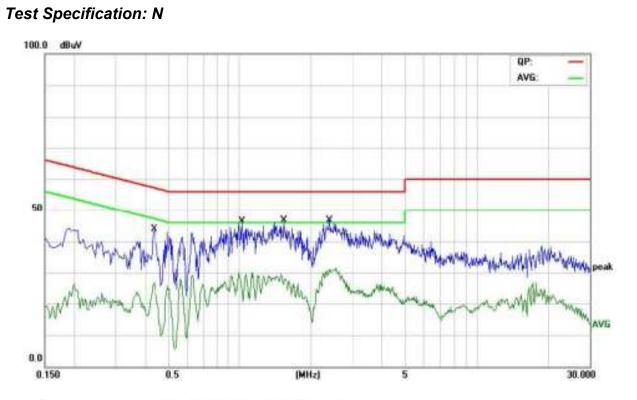
No.	Mk_	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.5540	19.75	9.46	29.21	46.00	-16.79	AVG	
2		0.5580	33.09	9.45	42.54	56.00	-13.46	QP	
3		1.1780	36.83	9.34	46.17	56.00	-9.83	QP	
4		1.1820	15.45	9.34	24.79	46.00	-21.21	AVG	
5	*	2.3620	37.57	9.38	46.95	56.00	-9.05	QP	
6		2.3820	17.38	9.38	26.76	46.00	-19.24	AVG	
7		3.6420	34.62	9.44	44.06	56.00	-11.94	QP	
8		3.6420	10.34	9.44	19.78	46.00	-26.22	AVG	





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Operating Condition: Normal



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.4340	34.37	9.60	43.97	57.18	-13.21	QP	
2		0.4351	16.39	9.59	25.98	47.15	+21.17	AVG	
3		1.0220	36.94	9.33	46.27	56.00	-9.73	QP	
4		1.0220	15.89	9.33	25.22	46.00	-20.78	AVG	
5		1.5339	37.20	9.35	46.55	56.00	-9.45	QP	
6		1.5339	17.20	9.35	26.55	46.00	-19.45	AVG	
7		2.3940	37.26	9.38	46.64	56.00	-9.36	QP	
8		2.3940	21.18	9,38	30.56	46.00	-15.44	AVG	



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5. Radiated Emission Test

5.1. Test Standard and Limit

5.1.1. Test Standard

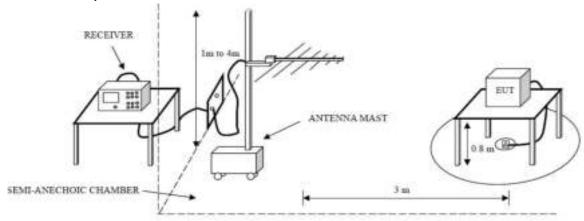
EN 55014-1: 2017.

5.1.2. Test Limit

Radiated Disturbance Test Limit

radiated Diotal Balloo 1 oot Elittic						
Fragueney	Limit (dBμV/m)					
Frequency	Quasi-peak Level					
30MHz~230MHz	40					
230MHz~1000MHz	47					
Remark: 1. The lower limit shall apply at the transition frequency.						
2. The test distance is 3m.						

5.2. Test Setup



5.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.



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5.4. Test Condition

Temperature	:	23 ℃
Relative Humidity	:	52 %
Pressure	:	1010 hPa
Test Power	:	DC 3V

5.5. Test Data

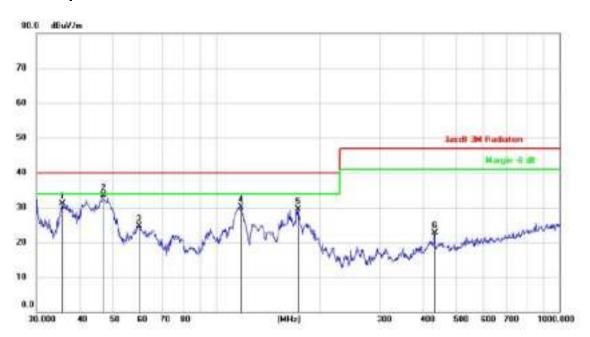
Please refer to the following pages.





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Operating Condition: Normal Test Specification: Horizontal



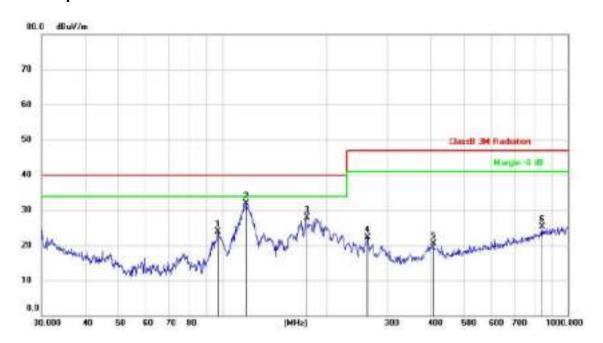
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dBuV/m	dBuV/m	dBuV/m	dB	Detector
1		35.7490	46.18	-15.04	31.14	40.00	-8.86	QP
2	*	46.8303	46.21	-12.69	33.52	40.00	-6.48	QP
3		59.8588	38.80	-14.15	24.65	40.00	-15.35	QP
4	į	118.1860	45.90	-15.78	30.12	40.00	-9.88	QP
5		173.8135	45.61	-16.17	29.44	40.00	-10.56	QP
6		432.5457	30.81	-8.07	22.74	47.00	-24.26	QP





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Operating Condition: Normal Test Specification: Vertical



No	. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dBuV/m	dBuV/m	dBuV/m	dB	Detector
1		97.1148	38.73	-14.92	23.81	40.00	-16.19	QP
2	*	117.3602	47.61	-15.64	31.97	40.00	-8.03	QP
3		175.6516	44.04	-16.06	27.98	40.00	-12.02	QP
4		262.8955	33.97	-11.66	22.31	47.00	-24.69	QP
5		407.5144	28.85	-8.43	20.42	47.00	-26.58	QP
6		842.1295	27.43	-2.16	25.27	47.00	-21.73	QP



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6.1. Test Requirements

6.1.1. Test Standard

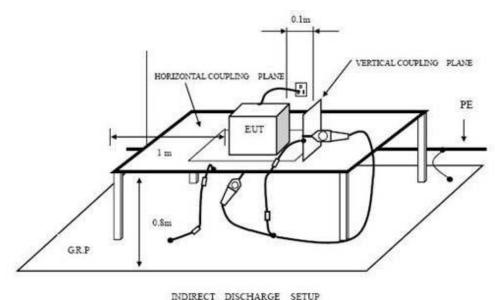
EN 55014-2: 2015 (EN 61000-4-2:2009)

6.1.2. Test Level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)		
1.0	±2	±2		
2.0	±4	±4		
3.0	±6	±8		
4.0	±8	±15		
Х	Special	Special		

6.1.3. Performance criterion: B

6.2. Test Setup



6.3. Test Procedure

6.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

6.3.2. Contact Discharge:



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All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

6.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

6.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

6.4. Test Data

Please refer to the following page.



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Electrostatic Discharge Test Result

EUT :	Facial Cleansing B	rush	M/N :	GT193	33
Temperature :	mperature : _22℃		Humidity :	50%	
Power supply :	DC 3V		Test Mode:	Normal	
Criterion: B					
Air Discharge:	±8kV Contact Disch	narge: ±4kV			
For each point	positive 10 times and	d negative 10	times discharç	ge.	
Location		Kind A-Air Discharge C-Contact Discharge			Result
Nonconductive	Enclosure	А			PASS
Button		А			PASS
Conductive End	closure	С			PASS
НСР		С			PASS
VCP of front		С			PASS
VCP of rear		С			PASS
VCP of left		С			PASS
VCP of right		С			PASS
Remark:					





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7. Radiated Electromagnetic Field Immunity test

7.1. Test Requirements

7.1.1. Test Standard

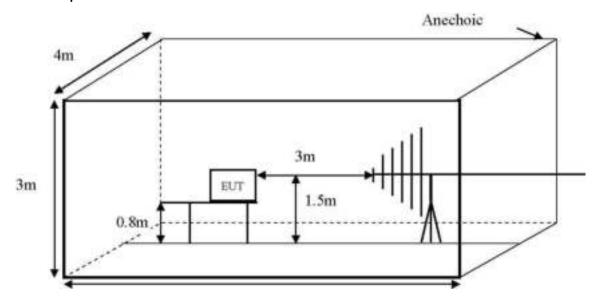
EN55014-2: 2015 (EN 61000-4-3: 2006 + A1: 2008 + A2:2010)

7.1.2. Test Level

Level	Field Strength V/m
1.0	1
2.0	3
3.0	10
X	Special

7.1.3. Performance criterion: A

7.2. Test Setup



7.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.



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All the scanning conditions are as following:

Condition of Test	Remark
Fielded Strength	3V/m (Severity Level 2)
Radiated Signal	Modulated
Scanning Frequency	80-1000MHz
Sweep time of radiated	0.0015 Decade/s
5. Dwell Time	1 Sec.

7.4. Test Data

Please refer to the following page.



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RF Field Strength Susceptibility Test Results

EUT : Facial Cleansing Brush M/N : GT1933

Temperature : 22° C Humidity : 50%

Power

supply : DC 3V Test Mode : Normal

Criterion: A

Modulation: Unmodulated

Pulse: AM 1KHz 80%

Pulse. Alvi IKHZ 80%							
	Frequency	y Range 1	Frequency Range 2				
	80~100	00MHz	1				
	Horizontal	Vertical	Horizontal	Vertical			
Front	PASS	PASS	1	1			
Right	PASS	PASS	1	1			
Rear	PASS	PASS	1	1			
Left	PASS	PASS	1	1			





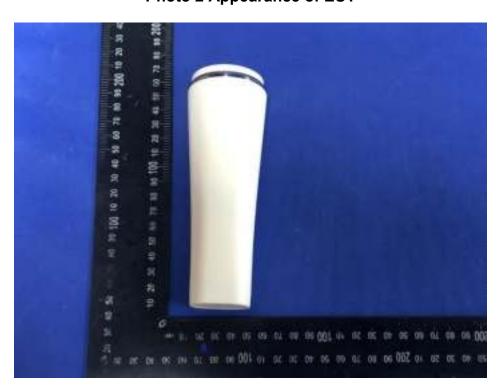
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8. Photographs - Constructional Details

Photo 1 Appearance of EUT



Photo 2 Appearance of EUT





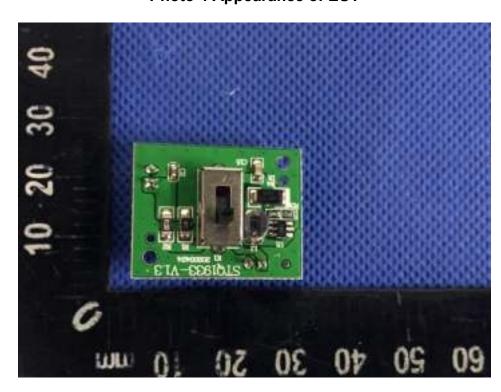


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Photo 3 Appearance of EUT



Photo 4 Appearance of EUT

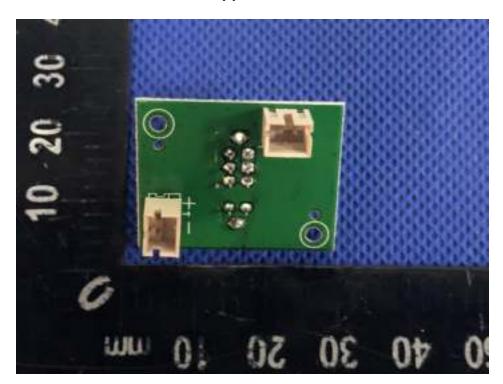






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Photo 5 Appearance of EUT



END OF REPORT